

**Search Notes****Application/Control No.**

10/742,919

**Examiner**

Tai Duong

**Applicant(s)/Patent under Reexamination**

LEE ET AL.

**Art Unit**

2871

**SEARCHED**

Class	Subclass	Date	Examiner
349	110, 111	2/8/2007	TD
	141, 153		
	156, 190		
430	5, 6		
	7, 20		
	321		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US PGPUB; USPAT; EPO; JPO; DERWENT; IBM TDB) see search history printout	2/8/2007	TD

**INTERFERENCE SEARCHED**

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